

Nemko Korea CO., Ltd.

300-2, Osan-Ri, Mohyun-Myun, Yongin-City, Kyungki-Do, KOREA

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FCC EVALUATION REPORT FOR CERTIFICATION

Applicant :

Samsung Electro-Mechanics Co., Ltd.
314, Maetan3-Dong, Paldal-Gu, Suwon-Shi,
Kyunggi-Do, Korea.
Attn : Mr. J. H. Lim

Dates of Issue : September 20, 2004
Test Report No. : NK2EE701
Test Site : Nemko Korea Co., Ltd.
EMC site, Korea

MODEL

E2XSPP1000R

Brand Name

SAMSUNG

CONTACT PERSON

Samsung Electro-Mechanics Co., Ltd.
314, Maetan3-Dong, Paldal-Gu, Suwon-Shi,
Kyunggi-Do, Korea.
Mr. J. H. Lim
Telephone No. : +82 31 210 6497

Applied Standard: Part 15 & 2
Classification : FCC Class B Device
EUT Type: Samsung Presenter

The device bearing the brand name and FCC ID specified above has been shown to comply with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in ANSI C63.4-2001.

I attest to the accuracy of data and all measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.



Tested By : J. H. Ko
Senior Engineer



Reviewed By : H.H. Kim
Manager & Chief Engineer

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SCOPE

Measurement and determination of electromagnetic emissions (EME) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission under FCC part 15.

Responsible Party :	Samsung Electro-Mechanics Co., Ltd.
Contact Person :	Mr. Jun-Hwan, Lim
Manufacturer :	1. Samsung Electro-Mechanics Co., Ltd. 314, Maetan3-Dong, Paldal-Gu, Suwon-Shi, Kyunggi-Do, Korea, 442-743. 2. Dongguan Samsung Electro-Mechanics Co., Ltd. Quan-Tang Village, Liao-Bu Town, Dong-Guan City, Guang-Dong Province P.R CHINA, 523425

- FCC ID: E2XSPP1000R
- Brand Name: SAMSUNG
- EUT Type: Samsung Presenter
- Voltage: DC 5V
- Port/Connector: USB 1.1

- Classification: FCC Class B
- Rule Part(s): FCC Part 15 & Part 2
- Test Procedure(s): ANSI C63.4 (2001)
- Dates of Test: September 13, 2004 to September 15, 2004
- Place of Tests: Nemko Korea Co., Ltd. EMC Site
- Test Report No.: NK2EE701

INTRODUCTION

The measurement procedure described in American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9kHz to 40GHz (ANSI C63.4-2001) was used in determining radiated and conducted emissions emanating from **Samsung Electro-Mechanics Co., Ltd.**

MODEL : **E2XSPP1000R, Samsung Presenter.**

These measurement tests were conducted at **Nemko Korea Co., Ltd. EMC Laboratory .**

The site address is 300-2, Osan-Ri, Mohyun-Myun, Yongin-City, Kyungki-Do, KOREA

The area of Nemko Korea Corporation Ltd. EMC Test Site is located in a mountain area at 80 kilometers (48 miles) southeast and Incheon International Airport (Incheon Airport), 30 kilometers (18miles) south-southeast from central Seoul.

It is located in the valley surrounded by mountains in all directions where ambient radio signal conditions are quiet and a favorable area to measure the radio frequency interference on open field test site for the computing and ISM devices manufactures.

The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4 on June 06, 2001.



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Fig. 1. The map above shows the Seoul in Korea vicinity area.
The map also shows Nemko Korea Corporation Ltd. EMC Lab. and Incheon Airport.

TEST CONDITIONS & EUT INFORMATION

Operating During Test

The EUT was connected with PC and was measured while presenter is giving and taking Data with a transmitter continuously.

Support Equipment

Samsung Presenter (EUT)	Samsung Electro-Mechanics Co., Ltd. FCC ID : E2XSPP1000R	S/N : N/A
Samsung Presenter (TX)	Samsung Electro-Mechanics Co., Ltd. Model : SPP1000T	S/N : N/A
PC	Dell Asia Pacific Sdn. Model : Precision 340 1.8m Unshielded AC power cable	S/N : N/A
Monitor	Sony EMCS Corp., Model : P992 1.8m Shield D-Sub cable 1.8m Unshielded Power cable	S/N : N/A
Keyboard	Solid Year Co., Ltd., Model : ACK-260 1.6m Unshielded Din cable	S/N : 910044844
PS/2 Mouse	Samsung Electro-Mechanics Model : SMO-5000WX 1.6m Unshielded Din cable	S/N : 03100016732
Serial Mouse	IO.TEC, Model : LASER MOUSE 1.5m Shielded D-Sub cable	S/N : N/A
Printer	Epson, Model: STYLUS C80 1.5m shielded D-sub cable 1.8m Unshielded Power cable	S/N : N/A

EUT Information

Clock:	6MHz, 16MHz
Chipset(s):	P4(USB-A), U2(CY7C63743), U3(AT93C46)
Port(s):	USB 1.1
Communication Protocol :	RF 2.4GHz

SUMMARY OF TEST RESULTS

The EUT has been tested according to the following specification:

Name of Test	Paragraph No.	Result	Remark
Conducted Emission	15.107(a)	Complies	
Radiated Emission	15.109(g)	Complies	

RECOMMENDATION/CONCLUSION

The data collected shows that the **Samsung Electro-Mechanics Co., Ltd.**

FCC ID : **E2XSPP1000R**, **Samsung Presenter**. complies with § 15.107 and 15.109 of the FCC Rules.

The highest emission observed was at **0.72 MHz** for conducted emissions with a A.V margin of **12.3 dB**, at **31.40 MHz** for radiated emissions with a margin of **10.3 dB**.

SAMPLE CALCULATION

$$\text{dB } \mu\text{V} = 20 \log_{10} (\mu\text{V}/\text{m})$$

$$\mu\text{V} = 10^{(\text{dB } \mu\text{V}/20)}$$

EX. 1.

@57.7 MHz

Class B limit = 100 $\mu\text{V}/\text{m}$ = 40.0 dB $\mu\text{V}/\text{m}$

Reading = 19.1 dB μV (calibrated level)

Antenna factor + Cable Loss + Amplifier Gain = 10.12 dB

Total = 29.22 dB $\mu\text{V}/\text{m}$

Margin = 40.0 – 29.22 = 10.78

10.78 dB below the limit

DESCRIPTION OF TESTS

Conducted Emissions

The Line conducted emission test facility is located inside a 4 X 7 X 2.5 meter shielded enclosure.

It is manufactured by EM engineering. The shielding effectiveness of the shielded room is in accordance with MIL-STD-285 or NSA 65-6.

A 1m X 1.5m wooden table 0.8m height is placed 0.4m away from the vertical wall and 1.5m away from the side of wall of the shielded room

Rohde & Schwarz (ESH3-Z5) and Kyoritsu (KNW-407) of the 50ohm/50uH Line Impedance Stabilization Network(LISN) are bonded to the shielded room.

The EUT is powered from the Rohde & Schwarz LISN and the support equipment is powered from the Kyoritsu LISN. Power to the LISN s are filtered by high-current high insertion loss Power line filters. The purpose of filter is to attenuate ambient signal interference and this filter is also bonded to shielded enclosure. All electrical cables are shielded by tinned copper zipper tubing with inner diameter of 1/2".

If DC power device, power will be derived from the source power supply it normally will be powered from and this supply lines will be connected to the LISNs,

All interconnecting cables more than 1 meter were shortened by non inductive bundling (serpentine fashion) to a 1 meter length.

Sufficient time for EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The RF output of the LISN was connected to the spectrum analyzer to determine the frequency producing the maximum EME from the EUT. The spectrum was scanned from 150kHz to 30MHz with 20msec sweep time.

The frequency producing the maximum level was re-examined using the EMI test receiver. (Rohde & Schwarz ESCS30).

The detector function were set to CISPR quasi-peak mode & average mode.

The bandwidth of receiver was set to 9KHz. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each EME emission.

Each emission was maximized by; switching power lines; varying the mode of operation or resolution; clock or data exchange speed; scrolling H pattern to the EUT and of support equipment, and powering the monitor from the floor mounted outlet box and computer aux AC outlet, if applicable; which ever determined the worst case emission.

Each EME reported was calibrated using the R&S signal generator.

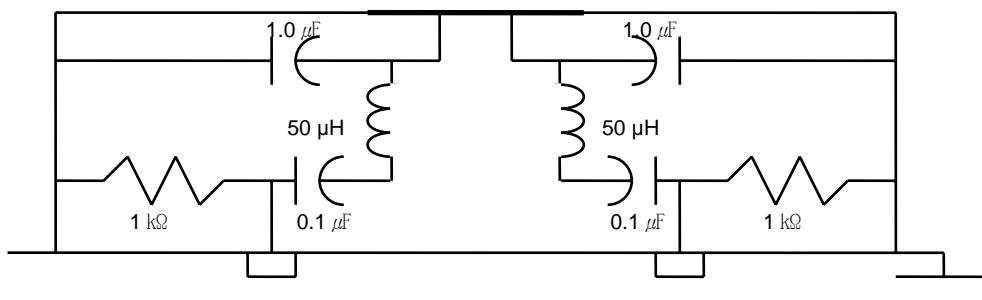


Fig. 2. LISN Schematic Diagram

DESCRIPTION OF TESTS

Radiated Emissions

Preliminary measurements were made indoors at 3 meter using broad band antennas, broadband amplifier, and spectrum analyzer to determine the frequency producing the maximum EME. Appropriate precaution was taken to ensure that all EME from the EUT were maximized and investigated. The Technology configuration, clock speed, mode of operation or video resolution, turntable azimuth with respect to the antenna was note for each frequency found.

The spectrum was scanned from 30 to 1000MHz using Biconical log Antenna(ARA, LPB-2520/A). Above 1GHz.

Final Measurements were made outdoors at 10m test range using Logbicon Super Antenna(Schwarzbeck, VULB9166).

The test equipment was placed on a wooden table.

Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition.

Each frequency found during pre-scan measurements was reexamined and investigated using EMI test receiver.(ESCS30)

The detector function was set to CISPR peak mode or quasi-peak mode or Average mode and the bandwidth of the receiver was set to 120KHz or 1MHz depending on the frequency or type of signal.

The half wave dipole antenna was tuned to the frequency found during preliminary radiated measurements.

The EUT support equipment and interconnecting cables were re configured to the setup producing the maximum emission for the frequency and were placed on top of a 0.8m high non- metallic 1.0X 1.5 meter table.

The EUT, support equipment and interconnecting cables were re-arranged and manipulated to maximize each EME emission.

The turn table containing the Technology was rotated; the antenna height was varied 1 to 4meter and stopped at the azimuth or height producing the maximum emission Each emission was maximized by : switching power lines; varying the mode of operation or resolution; clock or data exchange speed; scrolling H pattern to the EUT and of support equipment, and powering the monitor from the floor mounted outlet box and computer aux AC outlet, if applicable; which ever determined the worst case emission.

Each EME reported was calibrated using the R/S signal generator.

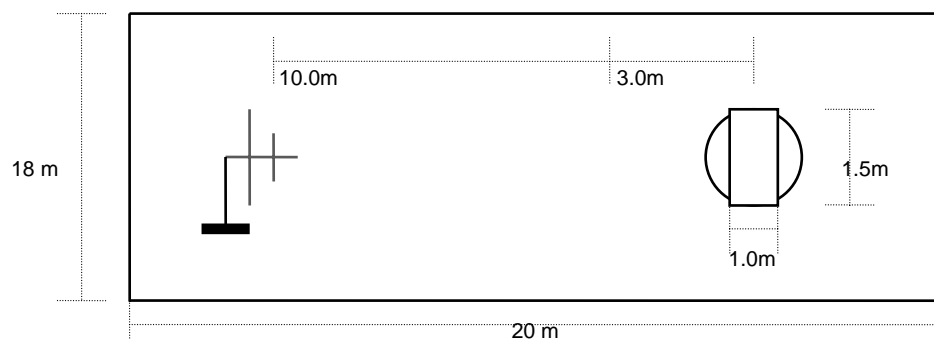


Fig. 3. Dimensions of Outdoor Test Site

TEST DATA

Radiated Emissions

FCC ID : E2XSPP1000R

Frequency (MHz)	Reading (dB μ V)	Pol* (H/V)	AF+CL+Amp (dB)**	Result (dB μ V/m)	Limit (dB μ V/m)	Margin (dB)
31.40	42.5	V	-22.8	19.7	30.0	10.3
34.50	38.5	V	-22.1	16.4	30.0	13.6
158.02	31.5	V	-12.8	18.7	30.0	11.3
165.63	32.3	H	-12.9	19.4	30.0	10.6
220.01	29.6	V	-13.2	16.4	30.0	13.6
298.06	29.8	H	-11.4	18.4	37.0	18.6

NOTES: Measurements using CISPR quasi-peak mode.

Table 2. Radiated Measurements at 10meters

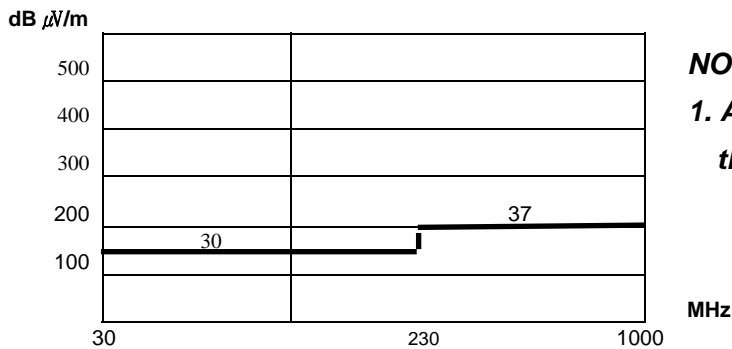


Fig. 4. Limits at 10 meters

NOTES:

1. All modes of operation were investigated the worst-case emission are reported.

NOTES:

1. Measurements using CISPR quasi-peak mode.
2. *Pol. H =Horizontal V=Vertical
3. **AF+CL+Amp. = Antenna Factor + Cable Loss + Amplifier.
4. The limit for Class B device is on the FCC Part section 15.109(g).



Tested by J. H. Ko

PLOTS OF EMISSIONS

- Conducted Emission at the Mains port (Line)

NEMKO KOREA

13 Sep 2004 17:38

Conducted Emissions

EUT: Presenter
 Manuf: Samsung Electro Mechanics
 Op Cond: AC 120V 60Hz
 Operator:
 Test Spec: FCC
 Comment: MODEL : SPP1000R
 LINE : L1
 Result File: spp1.dat : New Measurement

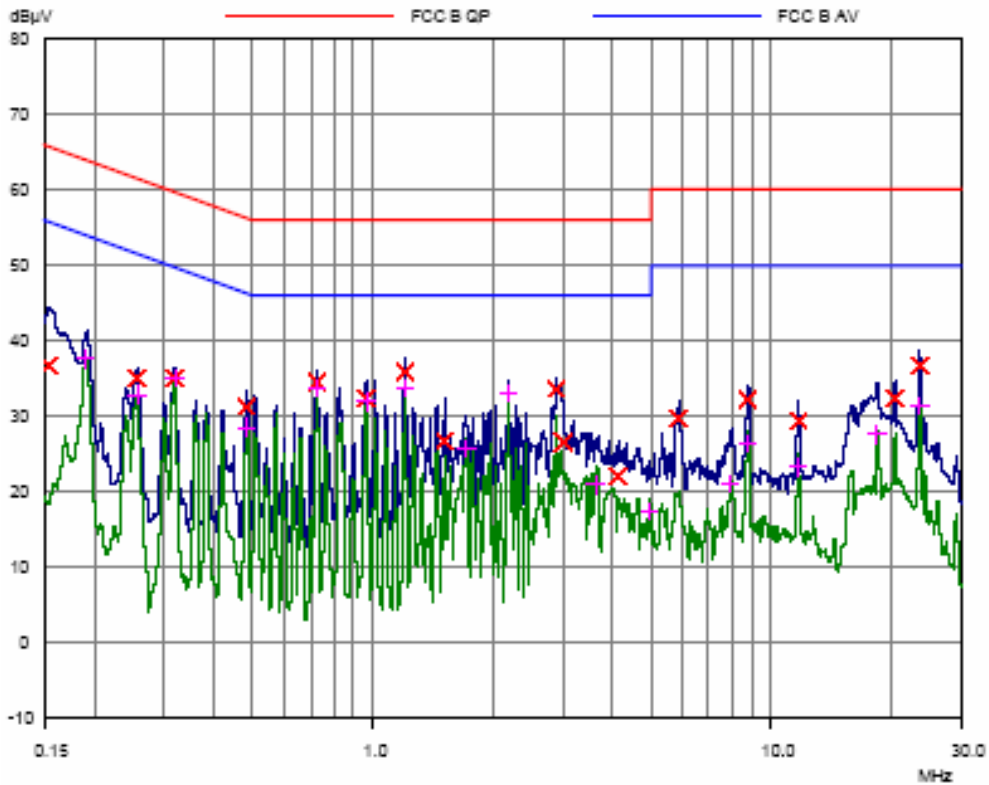
Scan Settings

(1 Range)

Frequencies			Receiver Settings						
Start	Stop	Step	IF BW	Detector	M-Time	Atten	Preamp	OpRge	
150kHz	30MHz	3.9063kHz	9kHz	PK+AV	20msec	10 dB	OFF	60dB	

Transducer	No.	Start	Stop	Name
	1	150kHz	30MHz	CE_LINE

Final Measurement: Detectors: X QP / + AV
 Meas Time: 1sec
 Subranges: 16
 Acc Margin: 50 dB



PLOTS OF EMISSIONS

- Conducted Emission at the Mains port (Neutral)

NEMKO KOREA 13 Sep 2004 18:00

Conducted Emissions

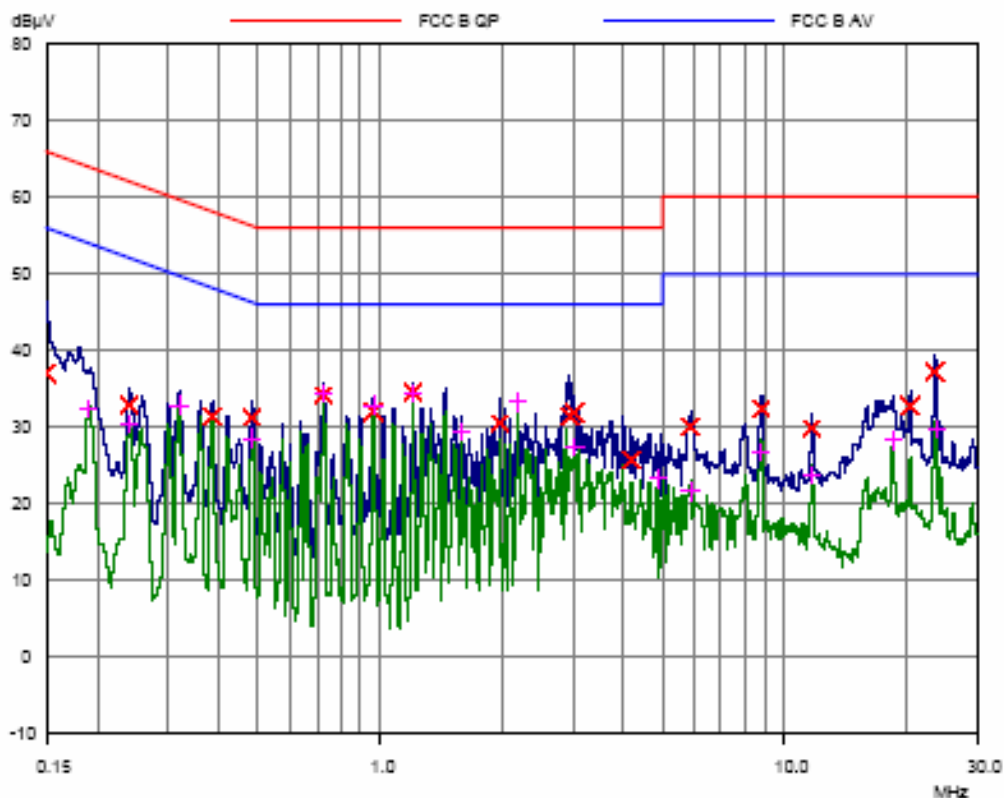
EUT: Presenter
 Manuf: Samsung Electro Mechanics
 Op Cond: AC 120V 60Hz
 Operator:
 Test Spec: FCC
 Comment: MODEL : SPP1000R
 LINE : Neutral
 Result File: sppn.dat : New Measurement

Scan Settings (1 Range)

Frequencies			Receiver Settings					
Start	Stop	Step	IF BW	Detector	M-Time	Atten	Preamp	OpRge
150kHz	30MHz	3.9063kHz	9kHz	PK+AV	20msec	10 dB	OFF	60dB

Transducer	No.	Start	Stop	Name
	1	150kHz	30MHz	CE_LINE

Final Measurement: Detectors: X QP / + AV
 Meas Time: 1sec
 Subranges: 16
 Acc Margin: 50 dB



ACCURACY OF MEASUREMENT

The Measurement Uncertainties stated were calculated in accordance with the requirements of NIST Technical Note 1297 with the confidence level of 95%

1. Radiation Uncertainty Calculation

<i>Contribution</i>	<i>Probability Distribution</i>	<i>Uncertainty(+/-dB)</i>
Antenna Factor	Normal (k=2)	± 0.5
Cable Loss	Normal (k=2)	± 0.04
Receiver Specification	Rectangular	± 2.0
Antenna directivity	Rectangular	± 1.0
Antenna Factor variation with Height		
Antenna Phase Center Variation		
Antenna Factor Frequency Interpolation		
Measurement Distance Variation		
Site Imperfections	Rectangular	± 2.0
Mismatch:Receiver VRC $r_i=0.3$ Antenna VRC $r_R=0.1(B_i)0.4(L_p)$ Uncertainty Limits $20\text{Log}(1+/-r_i r_R)$	U-Shaped	+ 0.25 / - 0.26
System Repeatibility	Std.deviation	± 0.05
Repeatability of EUT	-	-
Combined Standard Uncertainty	Normal	± 1.77
Expended Uncertainty U	Normal (k=2)	± 3.5

2. Conducted Uncertainty Calculation

<i>Contribution</i>	<i>Probability Distribution</i>	<i>Uncertainty(+/-dB)</i>
Receiver Specification	Normal (k=2)	± 2.0
LISN coupling spec.	Normal (k=2)	± 0.4
Cable and input attenuator cal.	Rectangular	± 0.4
Mismatch:Receiver VRC $r_i=0.3$ LISN vrc $r_g=0.1$ Uncertainty Limits $20\text{Log}(1+/-r_i r_R)$	U-Shaped	± 0.26
System Repeatibility	Std.deviation	± 0.68
Repeatability of EUT	-	-
Combined Standard Uncertainty	Normal	± 1.18
Expended Uncertainty U	Normal (k=2)	± 2.4

TEST EQUIPMENT

No.	Instrument	Manufacturer	Model	Calibration Date
1	*Test Receiver	R & S	ESCS 30	2004.08
2	*Test Receiver	R & S	ESCS 30	2003.12
3	*Amplifier	HP	8447F	2004.01
4	*Amplifier	HP	8447D	2004.07
5	Spectrum Analyzer	Advantest	R3265A	2003.12
6	*Spectrum Analyzer	HP	8566B	2004.03
7	*Logbicon Super Antenna	Schwarzbeck	VULB9166	2004.05
8	Doppels Teg Horn	EMCO	DAA-37121	2003.10
9	Dipole Antenna	R & S	VHA9103	2004.05
10	Dipole Antenna	R & S	UHA9105	2004.05
11	*Biconical Log Antenna	ARA	LPB-2520/A	2004.05
12	High Voltage Probe	R & S	ESH2-Z3	2003.10
13	Signal Generater	R & S	SMP02	2004.03
14	*LISN	R & S	ESH3-Z5	2003.11
15	*LISN	Kyoritsu	KNW-407	2004.03
16	LISN	Kyoritsu	KNW-408	2003.12
17	CDN	FCC	NCD-T4	2004.05
18	CDN	FCC	NCD-T2	2004.05
19	*Position Controller	EM Eng.	N/A	N/A
20	*Turn Table	EM Eng.	N/A	N/A
21	*Antenna Mast	EM Eng.	N/A	N/A
22	*Anechoic Chamber	EM Eng.	N/A	N/A

*) Test equipment used during the test

APPENDIX A – SAMPLE LABEL

Labelling Requirements

The sample label shown shall be *permanently affixed* at a conspicuous location on the device and be readily visible to the user at the time of purchase.

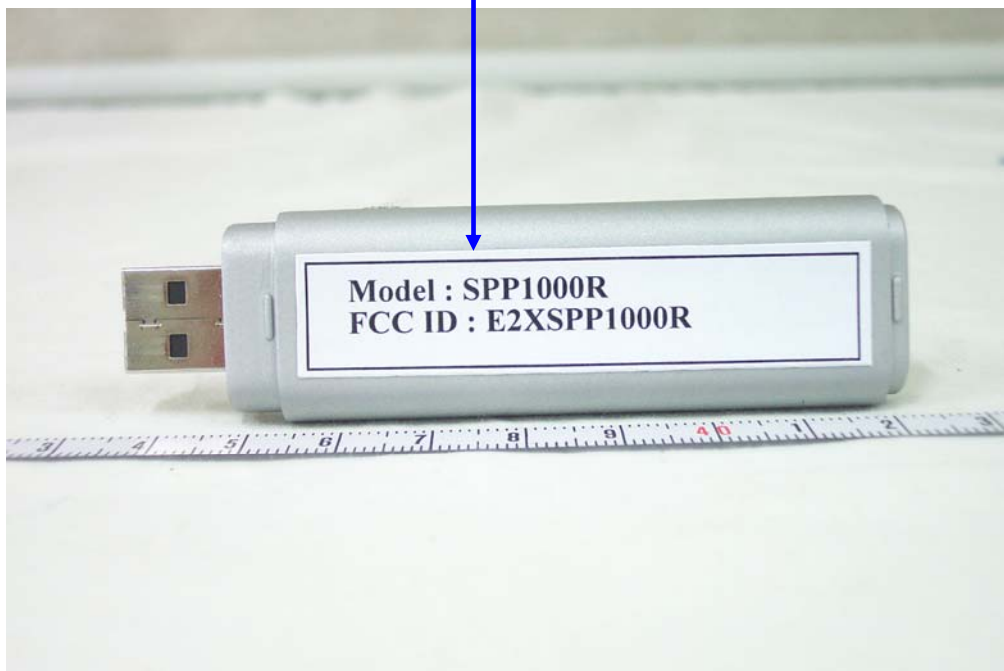
*** The following paragraph specified in the user manual.

This device complies with Part 15 of the FCC Rules. Operation is subject to the following two conditions : (1) this device may not cause harmful interference, and (2) this device must accept any interference received, including interference that may cause undesired operation.

MODEL NO : SPP1000R

FCC ID : E2XSPP1000R

- **FCC ID Location of EUT**



APPENDIX B – PHOTOGRAPHS OF TEST SET-UP

The **Conducted Test Picture** and **Radiated Test Picture** show the worst-case configuration and cable placement.

- **Conducted Test Picture(Front)**



- **Conducted Test Picture(Rear)**



● Radiated Test Picture(Front)



● Radiated Test Picture(Rear)



APPENDIX C – EUT PHOTOGRAPHS

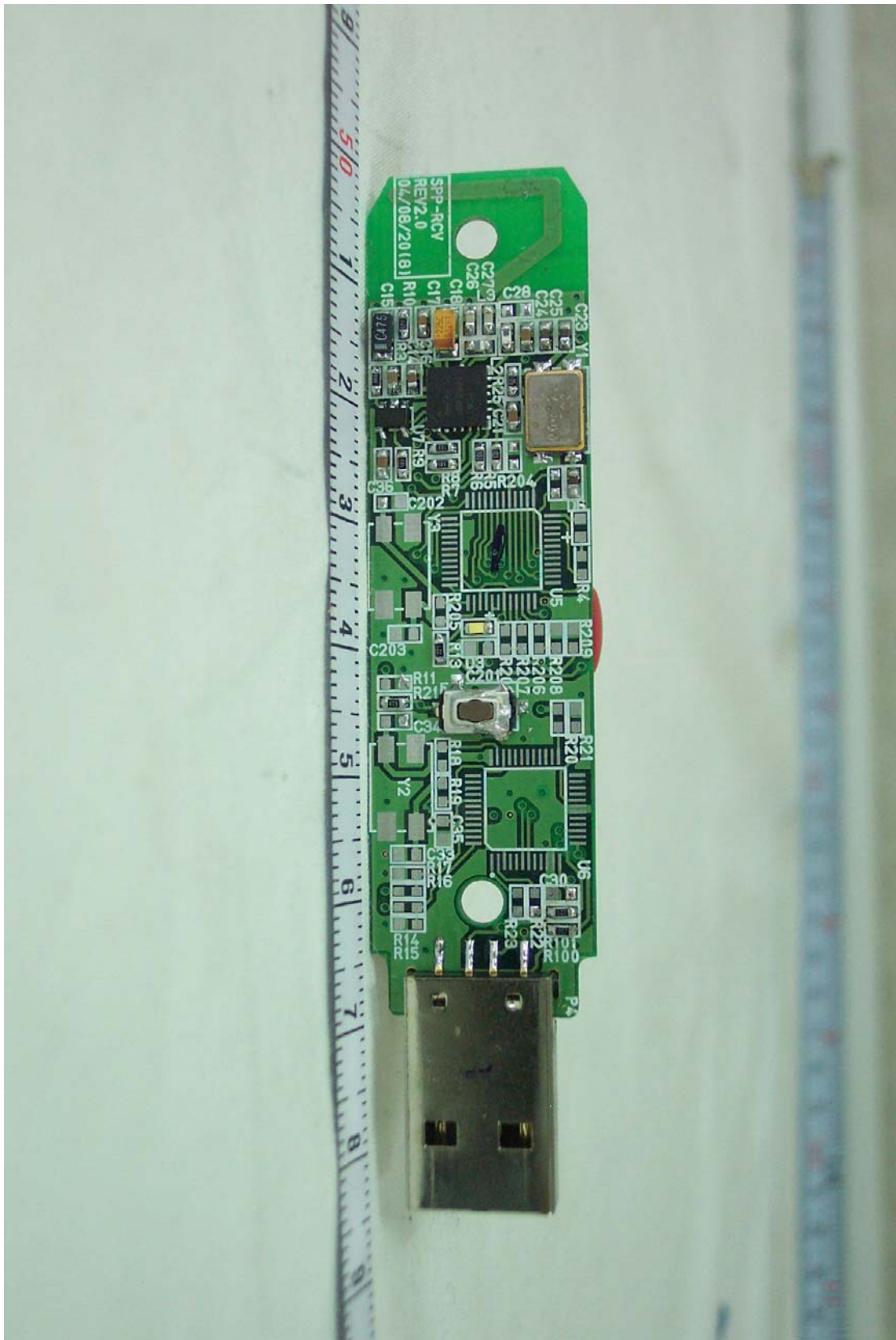
● Front View of EUT



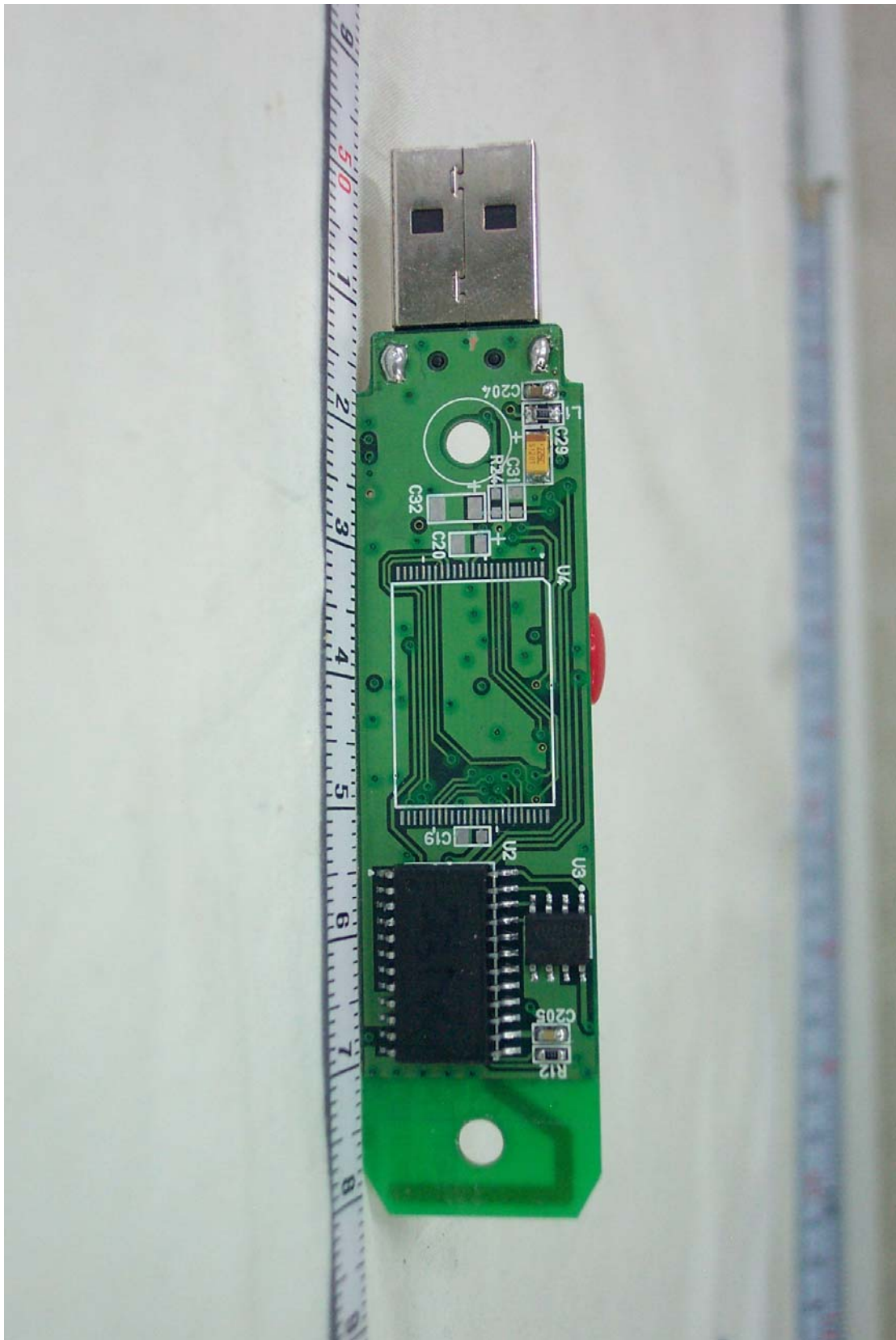
● Rear View of EUT



● Front View of Main Board



● Rear View of Main Board



APPENDIX D – BLOCK DIAGRAM

APPENDIX E – USER’S MANUAL

APPENDIX F – SCHEMATIC DIAGRAMS
